

Notice of References Cited	Application/Control No. 10/653,990		Applicant(s)/Patent Under Reexamination SHEU ET AL.	
	Examiner Jimmy Lin		Art Unit 1792	Page 1 of 1

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NON-PATENT DOCUMENTS

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*	U	English abstract of WO 02/41348; 5/23/2002
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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